


<p><b>Search Notes</b></p> 	<p><b>Application/Control No.</b></p> <p>10563669</p>	<p><b>Applicant(s)/Patent Under Reexamination</b></p> <p>NAKAYOSHI ET AL.</p>
	<p><b>Examiner</b></p> <p>LUCY P CHIEN</p>	<p><b>Art Unit</b></p> <p>2871</p>

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SEARCH NOTES		
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INTERFERENCE SEARCH			
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/LUCY P CHIEN/  
Examiner,Art Unit 2871